

# New Jersey Semi-Conductor Products, Inc.

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## IRF250/251/252/253

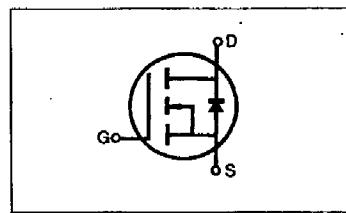
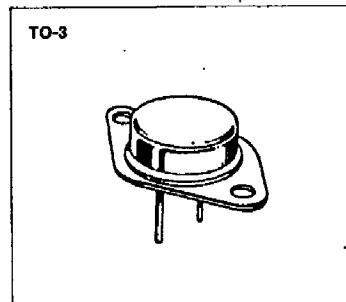
### N-CHANNEL POWER MOSFETS

#### FEATURES

- Low  $R_{DS(on)}$
- Improved Inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Low input capacitance
- Extended safe operating area
- Improved high temperature reliability
- TO-3 package (High current)

#### PRODUCT SUMMARY

Part Number	$V_{DS}$	$R_{DS(on)}$	$I_D$
IRF250	200V	0.085 Ω	30A
IRF251	150V	0.085 Ω	30A
IRF252	200V	0.12Ω	25A
IRF253	150V	0.12Ω	26A



#### MAXIMUM RATINGS

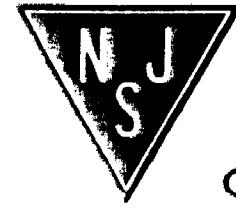
Characteristic	Symbol	IRF250	IRF251	IRF252	IRF253	Unit
Drain-Source Voltage (1)	$V_{DSS}$	200	150	200	150	Vdc
Drain-Gate Voltage ( $R_{GS}=1.0M\Omega$ ) (1)	$V_{DGR}$	200	150	200	150	Vdc
Gate-Source Voltage	$V_{GS}$	$\pm 20$				Vdc
Continuous Drain Current $T_c=25^\circ C$	$I_D$	30	30	25	25	Adc
Continuous Drain Current $T_c=100^\circ C$	$I_D$	19	19	16	16	Adc
Drain Current—Pulsed (3)	$I_{DM}$	120	120	100	100	Adc
Gate Current—Pulsed	$I_{GM}$	$\pm 1.5$				Adc
Total Power Dissipation @ $T_c=25^\circ C$ Derate above $25^\circ C$	$P_D$	150 1.2				Watts W/ $^\circ C$
Operating and Storage Junction Temperature Range	$T_J$ , $T_{Stg}$	−55 to 150				$^\circ C$
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 6 seconds	$T_L$	300				$^\circ C$

Notes: (1)  $T_J=25^\circ C$  to  $150^\circ C$

(2) Pulse test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

(3) Repetitive rating: Pulse width limited by max. junction temperature

NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.



**N-CHANNEL  
POWER MOSFETS**

**IRF250/251/252/253**

**ELECTRICAL CHARACTERISTICS** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Characteristic	Symbol	Type	Min	Typ	Max	Units	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	IRF250	200	—	—	V	$V_{\text{GS}}=0\text{V}$
		IRF252	—	—	—	—	
		IRF251	150	—	—	V	$I_D=250\mu\text{A}$
		IRF253	—	—	—	—	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	ALL	2.0	—	4.0	V	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$
Gate-Source Leakage Forward	$I_{\text{GSS}}$	ALL	—	—	100	nA	$V_{\text{GS}}=20\text{V}$
Gate-Source Leakage Reverse	$I_{\text{GSS}}$	ALL	—	—	-100	nA	$V_{\text{GS}}=-20\text{V}$
Zero Gate Voltage Drain Current	$I_{\text{GSS}}$	ALL	—	—	250	$\mu\text{A}$	$V_{\text{DS}}=\text{Max. Rating}, V_{\text{GS}}=0\text{V}$
		ALL	—	—	1000	$\mu\text{A}$	$V_{\text{DS}}=\text{Max. Rating} \times 0.8, V_{\text{GS}}=0\text{V}, T_C=125^\circ\text{C}$
On-State Drain-Source Current (2)	$I_{\text{D(on)}}$	IRF250	30	—	—	A	
		IRF251	—	—	—	—	$V_{\text{DS}} > I_{\text{D(on)}} \times R_{\text{DS(on)}} \text{ max.}, V_{\text{GS}}=10\text{V}$
		IRF252	25	—	—	A	
		IRF253	—	—	—	—	
Static Drain-Source On-State Resistance (2)	$R_{\text{DS(on)}}$	IRF250	—	0.07	0.085	$\Omega$	
		IRF251	—	—	—	—	$V_{\text{GS}}=10\text{V}; I_D=16\text{A}$
		IRF252	—	0.09	0.120	$\Omega$	
		IRF253	—	—	—	—	
Forward Transconductance (2)	$G_f$	ALL	8.0	12.5	—	$\Omega$	$V_{\text{DS}} > I_{\text{D(on)}} \times R_{\text{DS(on)}} \text{ max.}, I_D=16\text{A}$
Input Capacitance	$C_{\text{iss}}$	ALL	—	2640	3000	pF	
Output Capacitance	$C_{\text{oss}}$	ALL	—	800	1200	pF	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1.0\text{MHz}$
Reverse Transfer Capacitance	$C_{\text{rss}}$	ALL	—	300	500	pF	
Turn-On Delay Time	$t_{\text{d(on)}}$	ALL	—	—	35	ns	
Rise Time	$t_r$	ALL	—	—	100	ns	$V_{\text{DD}}=0.5\text{BV}_{\text{DSS}}, I_D=16\text{A}, Z_0=4.7 \Omega$
Turn-Off Delay Time	$t_{\text{d(off)}}$	ALL	—	—	125	ns	(MOSFET switching times are essentially independent of operating temperature.)
Fall Time	$t_f$	ALL	—	—	100	ns	
Total Gate Charge (Gate-Source Plus Gate-Drain)	$Q_g$	ALL	—	68	120	nC	$V_{\text{GS}}=10\text{V}, I_D=38\text{A}, V_{\text{DS}}=0.8 \text{ Max. Rating}$
Gate-Source Charge	$Q_{\text{gs}}$	ALL	—	18	—	nC	(Gate charge is essentially independent of operating temperature.)
Gate-Drain ("Miller") Charge	$Q_{\text{gd}}$	ALL	—	50	—	nC	

**THERMAL RESISTANCE**

Junction-to-Case	$R_{\text{thJC}}$	ALL	—	—	0.83	K/W
Case-to-Sink	$R_{\text{thCS}}$	ALL	—	0.1	—	K/W
Junction-to-Ambient	$R_{\text{thJA}}$	ALL	—	—	30	K/W

Notes: (1)  $T_J=25^\circ\text{C}$  to  $150^\circ\text{C}$

(2) Pulse test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$

(3) Repetitive rating: Pulse width limited by max. junction temperature

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POWER MOSFETS**

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

Characteristic	Symbol	Type	Min	Typ	Max	Units	Test Conditions
Continuous Source Current (Body Diode)	$I_S$	IRF250	—	—	30	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier
		IRF251	—	—	25	A	
		IRF252	—	—	25	A	
		IRF253	—	—	25	A	
Pulse Source Current (Body Diode) (3)	$I_{SM}$	IRF250	—	—	120	A	
		IRF251	—	—	100	A	
		IRF252	—	—	100	A	
		IRF253	—	—	100	A	
Diode Forward Voltage (2)	$V_{SD}$	IRF250	—	—	2.0	V	$T_c=25^\circ\text{C}$ , $I_s=30\text{A}$ , $V_{GS}=0\text{V}$
		IRF251	—	—	2.0	V	
		IRF252	—	—	1.8	V	
		IRF253	—	—	1.8	V	
Reverse Recovery Time	$t_r$	ALL	—	750	—	ns	$T_J=150^\circ\text{C}$ , $I_F=30\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$

Notes: (1)  $T_J=25^\circ\text{C}$  to  $150^\circ\text{C}$  (2) Pulse test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$   
(3) Repetitive rating: Pulse width limited by max. junction temperature

